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Technical Compliance

Report No.: ACS-E21141

The following product has been tested by us with the listed standards and found in compliance with the council EMC directive 2014/30/EU. It is demonstrative for the compliance with this EMC Directive.

Applicant : TPV Electronics (FuJian) Co., Ltd.
 Rongqiao Economic and Technological Development Zone,
 Fuqing City, Fujian Province, P.R. China

Product : LCD Monitor

Model No. : AG274Q; AG274QG; AG274Q*****
 (* = 0-9, A-Z, a-z, +, -, /, \ or blank)

Brand : AOC

Test Standards :	
EN 55032: 2015 / CISPR 32: 2015 (Class B) EN 55032: 2015+AC: 2016 CISPR32: 2015+COR1: 2016(Class B) EN 55032: 2015+A11: 2020(Class B) AS/NZS CISPR 32: 2015 AS/NZS CISPR 32: 2015+A1: 2020	Electromagnetic compatibility of multimedia equipment - Emission requirements
EN 61000-3-2: 2014 IEC 61000-3-2: 2014, Class D EN IEC 61000-3-2: 2019 IEC 61000-3-2: 2018, Class D	Electromagnetic Compatibility(EMC) Part 3-2:Limits-Limits for harmonic current emissions(equipment input current ≤ 16A per phase)
EN 61000-3-3: 2013 IEC 61000-3-3: 2013 EN 61000-3-3: 2013+A1: 2019 IEC 61000-3-3: 2013+A1: 2017	Electromagnetic Compatibility(EMC) Part 3-3:Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16A per phase and not subject to conditional connection
EN 55035: 2017 / CISPR 35: 2016 EN 55035: 2017+A11: 2020	Electromagnetic compatibility of multimedia equipment — Immunity requirements
IEC 61000-4-2: 2008	Electrostatic Discharge
IEC 61000-4-3: 2010	RF Field Strength Susceptibility
IEC 61000-4-4: 2012	Electrical Fast Transients
IEC 61000-4-5: 2014 IEC 61000-4-5: 2014+A1: 2017	Surge
IEC 61000-4-6: 2013	Continuous Conducted Disturbance
IEC 61000-4-8: 2009	Magnetic Field Immunity
IEC 61000-4-11: 2004 IEC 61000-4-11: 2004+A1: 2017 IEC 61000-4-11: 2020	Immunity to Voltage Interruption Variation



Stamp only for EMC Dept. Report

Signature: Bensun Chen

Bensun Chen
 Manager

Date : May.17, 2021

The technical compliance is based on a single evaluation of one sample of above mentioned product. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.